

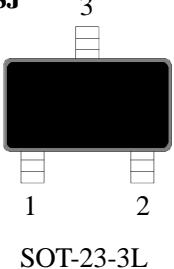
## 1、Description

**PNP**N devices designed for high volume, line-powered consumer applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in an inexpensive plastic **SOT-23-3L** package which is readily adaptable for use in automatic insertion equipment.

## 2、Features

- Sensitive gate allows triggering by micro-controllers and other logic circuits
- Blocking voltage to 800 volts
- On-state RMS current to 1.0A RMS at 50°C
- Ultra low gate trigger current
- Glass-Passivated Surface for Reliability and Uniformity

## 3、Pinning information

PIN	Description	Simplified outline	Symbol
1	Cathode ( K )	<b>CODE: CS18J</b>  <b>SOT-23-3L</b>	
2	Gate ( G )		
3	Anode ( A )		

## 4、Quick reference data

SYMBOL	PARAMETER	MAX	UNIT
<b>V<sub>DRM</sub> V<sub>RRM</sub></b>	Repetitive peak off-state voltages	800	V
<b>I<sub>T(RMS)</sub></b>	RMS on-state current	1.0	A
<b>I<sub>TSM</sub></b>	Non-repetitive peak on-state current	10	A
<b>I<sub>GT</sub></b>	Gate trigger current	100	uA

## 5、Thermal characteristics

SYMBOL	PARAMETER	Value	UNIT
<b>R<sub>th(j-c)</sub></b>	junction to case(AC)	80	°C/W

## 6、Limiting value

Limiting values in accordance with the Maximum System(IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
$V_{DRM}$	Repetitive peak off-state voltages		-	800	V
$I_{T(RMS)}$	RMS on-state current	Full Cycle Sine Wave 50 to 60 Hz (TC = 50°C)	-	1.0	A
$I_{TSM}$	Non-repetitive peak Surge current	One Full cycle, 60 Hz, $T_J = +110^\circ\text{C}$	-	10	A
$I^2t$	$I^2t$ for fusing	$t = 8.3\text{ms}$	-	0.32	$\text{A}^2\text{s}$
$V_{GM}$	Peak gate voltage	Pulse Width $\leq 1.0 \mu\text{s}$ , TC = 85°C	-	5	V
$P_{GM}$	Peak gate power	Pulse Width $\leq 1.0 \mu\text{s}$ , TC = 85°C	-	0.5	W
$P_{G(AV)}$	Average gate power	Pulse Width $\leq 1.0 \mu\text{s}$ , TC = 85°C	-	0.1	W
$T_{stg}$	Storage temperature		-40	150	$^\circ\text{C}$
$T_j$	Operating junction temperature		-40	110	$^\circ\text{C}$

## 7、Characteristics

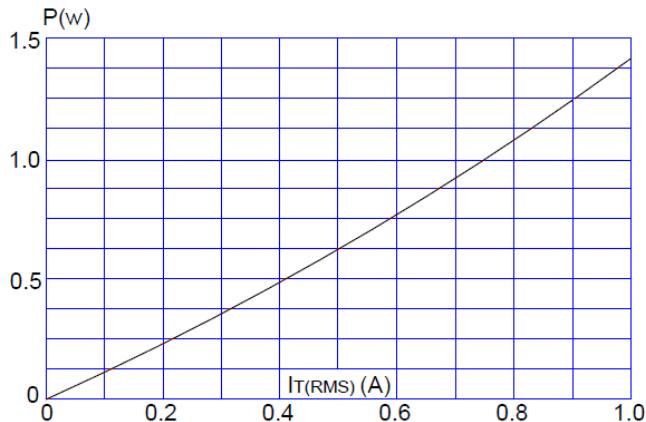
$T_J = 25^\circ\text{C}$  unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
<b>Static characteristics</b>						
$I_{GT}$	Gate trigger current	$V_D = 12 \text{ V}; RL = 33\Omega$	-	50	100	uA
$I_L$	Latching current	$I_G = 1.2 \times I_{GT}$	-	-	5	mA
$I_H$	Holding current	$IT = 0.05 \text{ mA}$	-	-	3	mA
$V_{TM}$	On-state voltage	$I_{TM} = 1.1 \text{ A}$ tp=380μs	-	-	1.50	V
$V_{GT}$	Gate trigger voltage	$V_D = 12 \text{ V}; RL = 33\Omega$	-	-	0.8	V
$V_{GD}$	Gate Non-Trigger Voltage	$V_D = V_{DRM}; T_j = 110^\circ\text{C}$	0.2	-	-	V
$I_{DRM}$ $I_{RRM}$	$V_D = V_{DRM}$ $V_R = V_{RRM}$	$T_j = 25^\circ\text{C}$	-	-	5	uA
		$T_j = 110^\circ\text{C}$	-	-	500	uA
<b>Dynamic Characteristics</b>						
$dV/dt$	Critical rate of rise of off-state voltage	$V_D = 2/3 V_{DRM}$ Gate Open $T_j = 110^\circ\text{C}$	20	35	-	V/μs

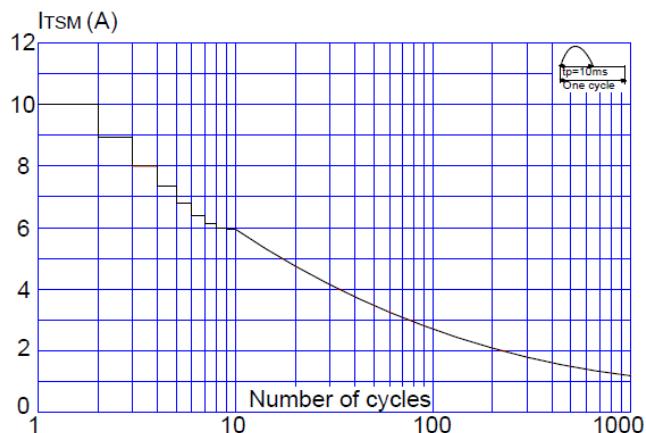
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## 8、Electrical Characteristics Curve

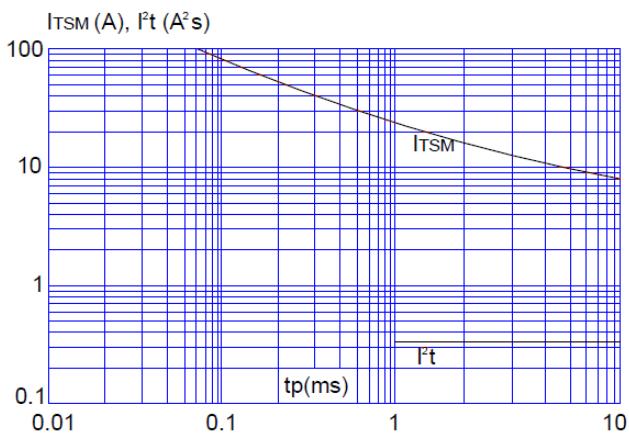
**FIG.1** Maximum power dissipation versus RMS on-state current



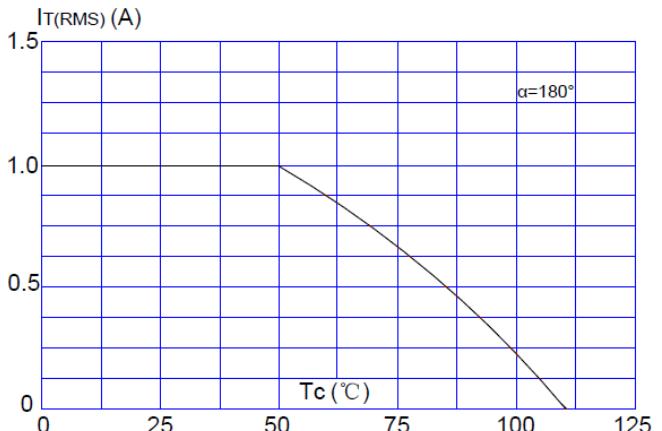
**FIG.3:** Surge peak on-state current versus number of cycles



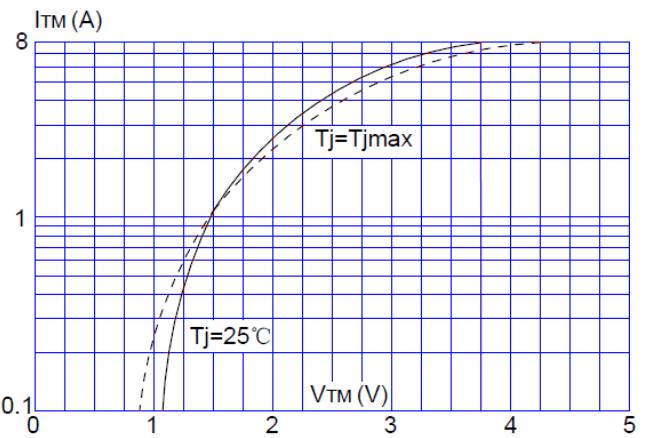
**FIG.5:** Non-repetitive surge peak on-state current for a sinusoidal pulse with width  $t_p < 10\text{ms}$ , and corresponding value of  $I^2t$



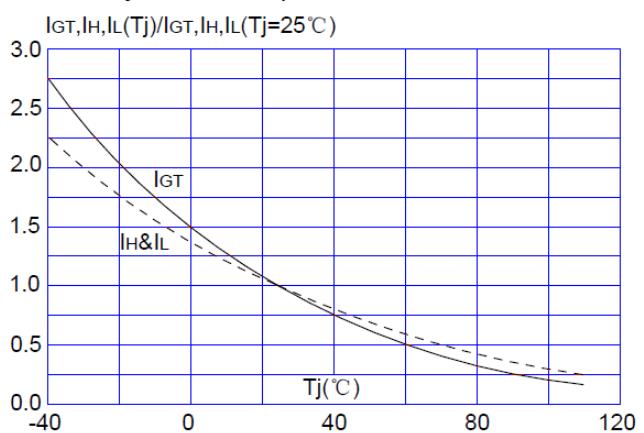
**FIG.2:** RMS on-state current versus case temperature



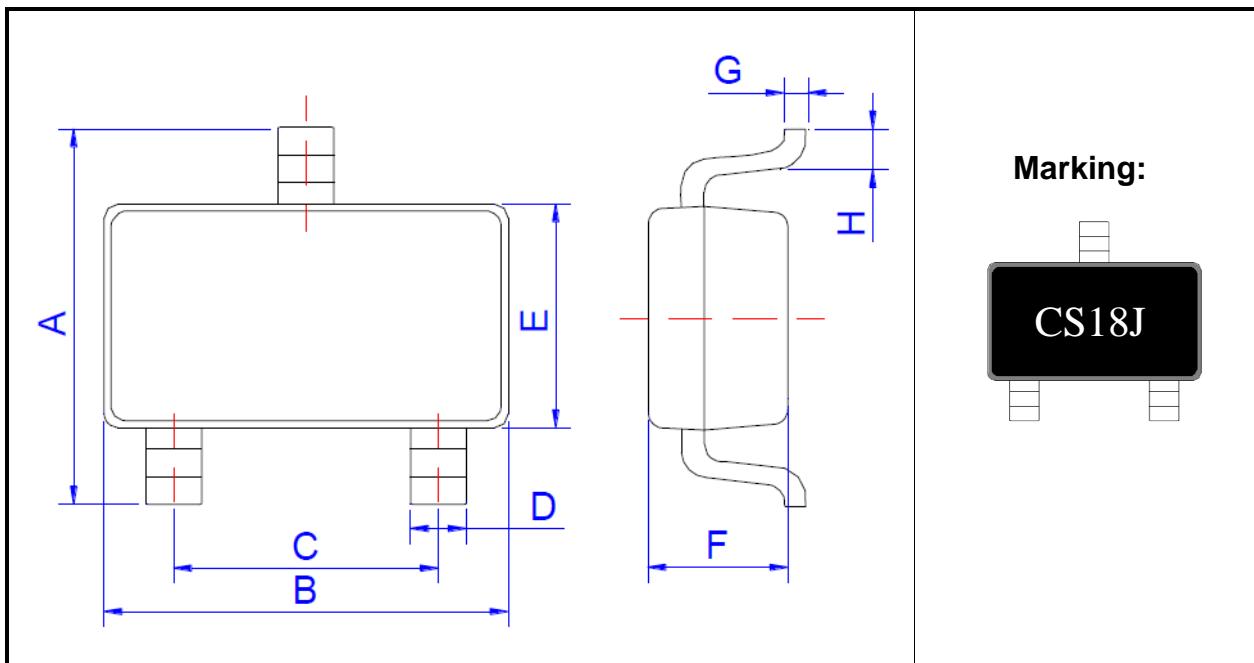
**FIG.4:** On-state characteristics (maximum values)



**FIG.6:** Relative variations of gate trigger current, holding current and latching current versus junction temperature



## 9、Package outline(SOT-23-3L)



DIM	Inches			Millimeters		
	Min	Type	Max	Min	Type	Max
A	0.104		0.116	2.65		2.95
B		0.115			2.92	
C		0.075			1.90	
D	0.014		0.018	0.35		0.45
E		0.064			1.62	
F		0.043			1.10	
G		0.006			0.16	
H	0.010		0.022	0.25		0.55

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